

Application/Control No.	Applicant(s)/Patent under Reexamination MAEHIRO, KAZUTOYO	
09/820,530		
Examiner	Art Unit	
Philip C. Lee	2152	

SEARCHED					
Class	Subclass	Date	Examine		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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	DATE	EXMR
keywords search in EAST	6/26/2007	PL
keywords search in EAST	6/27/2007	PL
keywords search in EAST	7/2/2007	PL